# Altera - EP1S40B956C5 Datasheet





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#### Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

# Details

Product Status	Active
Number of LABs/CLBs	4125
Number of Logic Elements/Cells	41250
Total RAM Bits	3423744
Number of I/O	683
Number of Gates	-
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	956-BBGA, FCBGA
Supplier Device Package	956-BGA (40x40)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=ep1s40b956c5

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Table 1–5. Stratix FineLine BGA Package Sizes									
Dimension	484 Pin	672 Pin	780 Pin	1,020 Pin	1,508 Pin				
Pitch (mm)	1.00	1.00	1.00	1.00	1.00				
Area (mm <sup>2</sup> )	529	729	841	1,089	1,600				
$\begin{array}{l} \text{Length}\times\text{ width}\\ (\text{mm}\times\text{ mm}) \end{array}$	23 × 23	27 × 27	29 × 29	33 × 33	40×40				

Stratix devices are available in up to four speed grades, -5, -6, -7, and -8, with -5 being the fastest. Table 1–6 shows Stratix device speed-grade offerings.

Table 1–6. Stratix Device Speed Grades										
Device	672-Pin BGA	956-Pin BGA	484-Pin FineLine BGA	672-Pin FineLine BGA	780-Pin FineLine BGA	1,020-Pin FineLine BGA	1,508-Pin FineLine BGA			
EP1S10	-6, -7		-5, -6, -7	-6, -7	-5, -6, -7					
EP1S20	-6, -7		-5, -6, -7	-6, -7	-5, -6, -7					
EP1S25	-6, -7			-6, -7, -8	-5, -6, -7	-5, -6, -7				
EP1S30		-5, -6, -7			-5, -6, -7, -8	-5, -6, -7				
EP1S40		-5, -6, -7			-5, -6, -7, -8	-5, -6, -7	-5, -6, -7			
EP1S60		-6, -7				-5, -6, -7	-6, -7			
EP1S80		-6, -7				-5, -6, -7	-5, -6, -7			



Each LE's programmable register can be configured for D, T, JK, or SR operation. Each register has data, true asynchronous load data, clock, clock enable, clear, and asynchronous load/preset inputs. Global signals, general-purpose I/O pins, or any internal logic can drive the register's clock and clear control signals. Either general-purpose I/O pins or internal logic can drive the clock enable, preset, asynchronous load, and asynchronous data. The asynchronous load data input comes from the data3 input of the LE. For combinatorial functions, the register is bypassed and the output of the LUT drives directly to the outputs of the LE.

Each LE has three outputs that drive the local, row, and column routing resources. The LUT or register output can drive these three outputs independently. Two LE outputs drive column or row and direct link routing connections and one drives local interconnect resources. This allows the LUT to drive one output while the register drives another output. This feature, called register packing, improves device utilization because the device can use the register and the LUT for unrelated

### Figure 2–5. Stratix LE



Figure 2–10. LUT Chain & Register Chain Interconnects

The C4 interconnects span four LABs, M512, or M4K blocks up or down from a source LAB. Every LAB has its own set of C4 interconnects to drive either up or down. Figure 2–11 shows the C4 interconnect connections from an LAB in a column. The C4 interconnects can drive and be driven by all types of architecture blocks, including DSP blocks, TriMatrix memory blocks, and vertical IOEs. For LAB interconnection, a primary LAB or its LAB neighbor can drive a given C4 interconnect. C4 interconnects can drive each other to extend their range as well as drive row interconnects for column-to-column connections. C8 interconnects span eight LABs, M512, or M4K blocks up or down from a source LAB. Every LAB has its own set of C8 interconnects to drive either up or down. C8 interconnect connections between the LABs in a column are similar to the C4 connections shown in Figure 2–11 with the exception that they connect to eight LABs above and below. The C8 interconnects can drive and be driven by all types of architecture blocks similar to C4 interconnects. C8 interconnects can drive each other to extend their range as well as R8 interconnects for column-to-column connections. C8 interconnects are faster than two C4 interconnects.

C16 column interconnects span a length of 16 LABs and provide the fastest resource for long column connections between LABs, TriMatrix memory blocks, DSP blocks, and IOEs. C16 interconnects can cross M-RAM blocks and also drive to row and column interconnects at every fourth LAB. C16 interconnects drive LAB local interconnects via C4 and R4 interconnects and do not drive LAB local interconnects directly.

All embedded blocks communicate with the logic array similar to LABto-LAB interfaces. Each block (i.e., TriMatrix memory and DSP blocks) connects to row and column interconnects and has local interconnect regions driven by row and column interconnects. These blocks also have direct link interconnects for fast connections to and from a neighboring LAB. All blocks are fed by the row LAB clocks, labclk [7..0].

Table 2–2. Stratix Device Routing Scheme																	
								Des	stinat	ion							
Source	LUT Chain	Register Chain	Local Interconnect	Direct Link Interconnect	R4 Interconnect	R8 Interconnect	R24 Interconnect	C4 Interconnect	C8 Interconnect	C16 Interconnect	TE	M512 RAM Block	M4K RAM Block	M-RAM Block	DSP Blocks	Column IOE	Row IOE
LUT Chain											$\checkmark$						
Register Chain											$\checkmark$						
Local Interconnect											>	~	~	>	~	>	~
Direct Link Interconnect			~														
R4 Interconnect			$\checkmark$		$\checkmark$		$\checkmark$	$\checkmark$		$\checkmark$							
R8 Interconnect			$\checkmark$			$\checkmark$			$\checkmark$								
R24 Interconnect					~		~	~		~							
C4 Interconnect			$\checkmark$		$\checkmark$			$\checkmark$									
C8 Interconnect			$\checkmark$			$\checkmark$			$\checkmark$								
C16 Interconnect					~		~	~		~							
LE	>	$\checkmark$	>	~	~	>		~	<								
M512 RAM Block			~	>	>	~		>	~								
M4K RAM Block			$\checkmark$	$\checkmark$	$\checkmark$	$\checkmark$		$\checkmark$	$\checkmark$								
M-RAM Block								~	<								
DSP Blocks			$\checkmark$	$\checkmark$	$\checkmark$	$\checkmark$		$\checkmark$	$\checkmark$								
Column IOE				$\checkmark$				$\checkmark$	$\checkmark$	$\checkmark$							
Row IOE				~		$\checkmark$	~	~	$\checkmark$	$\checkmark$							

Table 2–2 shows the Stratix device's routing scheme.



Figure 2–21. Left-Facing M-RAM to Interconnect Interface Notes (1), (2)

#### Notes to Figure 2–21:

- (1) Only R24 and C16 interconnects cross the M-RAM block boundaries.
- (2) The right-facing M-RAM block has interface blocks on the right side, but none on the left. B1 to B6 and A1 to A6 orientation is clipped across the vertical axis for right-facing M-RAM blocks.



Figure 2–26. Input/Output Clock Mode in Simple Dual-Port Mode Notes (1), (2)

#### Notes to Figure 2–26:

- (1) All registers shown except the rden register have asynchronous clear ports.
- (2) Violating the setup or hold time on the address registers could corrupt the memory contents. This applies to both read and write operations.



#### Figure 2–45. EP1S30 Device Fast Regional Clock Pin Connections to Fast Regional Clocks

#### Notes to Figure 2-45:

- (1) This is a set of two multiplexers.
- (2) In addition to the FCLK pin inputs, there is also an input from the I/O interconnect.

#### Combined Resources

Within each region, there are 22 distinct dedicated clocking resources consisting of 16 global clock lines, four regional clock lines, and two fast regional clock lines. Multiplexers are used with these clocks to form eight bit busses to drive LAB row clocks, column IOE clocks, or row IOE clocks. Another multiplexer is used at the LAB level to select two of the eight row clocks to feed the LE registers within the LAB. See Figure 2–46.



Figure 2–47. EP1S10, EP1S20 & EP1S25 Device I/O Clock Groups

The variation due to process, voltage, and temperature is about  $\pm 15\%$  on the delay settings. PLL reconfiguration can control the clock delay shift elements, but not the VCO phase shift multiplexers, during system operation.

# Spread-Spectrum Clocking

Stratix device enhanced PLLs use spread-spectrum technology to reduce electromagnetic interference generation from a system by distributing the energy over a broader frequency range. The enhanced PLL typically provides 0.5% down spread modulation using a triangular profile. The modulation frequency is programmable. Enabling spread-spectrum for a PLL affects all of its outputs.

# Lock Detect

The lock output indicates that there is a stable clock output signal in phase with the reference clock. Without any additional circuitry, the lock signal may toggle as the PLL begins tracking the reference clock. You may need to gate the lock signal for use as a system control. The lock signal from the locked port can drive the logic array or an output pin.

Whenever the PLL loses lock (for example, inclk jitter, clock switchover, PLL reconfiguration, power supply noise, and so on), the PLL must be reset with the areset signal to guarantee correct phase relationship between the PLL output clocks. If the phase relationship between the input clock versus output clock, and between different output clocks from the PLL is not important in the design, then the PLL need not be reset.



See the *Stratix FPGA Errata Sheet* for more information on implementing the gated lock signal in a design.

# Programmable Duty Cycle

The programmable duty cycle allows enhanced PLLs to generate clock outputs with a variable duty cycle. This feature is supported on each enhanced PLL post-scale counter (*g*0..*g*3, *l*0..*l*3, *e*0..*e*3). The duty cycle setting is achieved by a low and high time count setting for the post-scale dividers. The Quartus II software uses the frequency input and the required multiply or divide rate to determine the duty cycle choices.

# Advanced Clear & Enable Control

There are several control signals for clearing and enabling PLLs and their outputs. You can use these signals to control PLL resynchronization and gate PLL output clocks for low-power applications.

Table 2–26. External RAM Support in EP1860 & EP1880 Devices								
	I/O Standard	Maximum Clock Rate (MHz)						
DDA Memory Type	i/U Stalluaru	-5 Speed Grade	-6 Speed Grade	-7 Speed Grade				
DDR SDRAM (1), (2)	SSTL-2	167	167	133				
DDR SDRAM - side banks (2), (3)	SSTL-2	150	133	133				
QDR SRAM (4)	1.5-V HSTL	133	133	133				
QDRII SRAM (4)	1.5-V HSTL	167	167	133				
ZBT SRAM (5)	LVTTL	200	200	167				

Table 2–26. External RAM Support in EP1S60 & EP1S80 Devices

Notes to Table 2–26:

 These maximum clock rates apply if the Stratix device uses DQS phase-shift circuitry to interface with DDR SDRAM. DQS phase-shift circuitry is only available in the top and bottom I/O banks (I/O banks 3, 4, 7, and 8).

(2) For more information on DDR SDRAM, see AN 342: Interfacing DDR SDRAM with Stratix & Stratix GX Devices.

(3) DDR SDRAM is supported on the Stratix device side I/O banks (I/O banks 1, 2, 5, and 6) without dedicated DQS phase-shift circuitry. The read DQS signal is ignored in this mode. Numbers are preliminary.

(4) For more information on QDR or QDRII SRAM, see AN 349: QDR SRAM Controller Reference Design for Stratix & Stratix GX Devices.

(5) For more information on ZBT SRAM, see AN 329: ZBT SRAM Controller Reference Design for Stratix & Stratix GX Devices.

In addition to six I/O registers and one input latch in the IOE for interfacing to these high-speed memory interfaces, Stratix devices also have dedicated circuitry for interfacing with DDR SDRAM. In every Stratix device, the I/O banks at the top (I/O banks 3 and 4) and bottom (I/O banks 7 and 8) of the device support DDR SDRAM up to 200 MHz. These pins support DQS signals with DQ bus modes of ×8, ×16, or ×32.

Table 2–27 shows the number of DQ and DQS buses that are supported per device.

Table 2–27	Table 2-27. DQS & DQ Bus Mode Support (Part 1 of 2) Note (1)								
Device	Package	Number of ×8 Groups	Number of ×16 Groups	Number of ×32 Groups					
EP1S10	672-pin BGA 672-pin FineLine BGA	12 (2)	0	0					
	484-pin FineLine BGA 780-pin FineLine BGA	16 (3)	0	4					
EP1S20	484-pin FineLine BGA	18(4)	7 (5)	4					
	672-pin BGA 672-pin FineLine BGA	16(3)	7 (5)	4					
	780-pin FineLine BGA	20	7 (5)	4					

synthesis, allowing real-time variation of the PLL frequency and delay. The rest of the device is functional while reconfiguring the PLL. See the *Stratix Architecture* chapter of the *Stratix Device Handbook, Volume 1* for more information on Stratix PLLs.

# **Remote Update Configuration Modes**

Stratix devices also support remote configuration using an Altera enhanced configuration device (e.g., EPC16, EPC8, and EPC4 devices) with page mode selection. Factory configuration data is stored in the default page of the configuration device. This is the default configuration that contains the design required to control remote updates and handle or recover from errors. You write the factory configuration once into the flash memory or configuration device. Remote update data can update any of the remaining pages of the configuration device. If there is an error or corruption in a remote update configuration, the configuration device reverts back to the factory configuration information.

There are two remote configuration modes: remote and local configuration. You can use the remote update configuration mode for all three configuration modes: serial, parallel synchronous, and parallel asynchronous. Configuration devices (for example, EPC16 devices) only support serial and parallel synchronous modes. Asynchronous parallel mode allows remote updates when an intelligent host is used to configure the Stratix device. This host must support page mode settings similar to an EPC16 device.

# Remote Update Mode

When the Stratix device is first powered up in remote update programming mode, it loads the configuration located at page address "000." The factory configuration should always be located at page address "000," and should never be remotely updated. The factory configuration contains the required logic to perform the following operations:

- Determine the page address/load location for the next application's configuration data
- Recover from a previous configuration error
- Receive new configuration data and write it into the configuration device

The factory configuration is the default and takes control if an error occurs while loading the application configuration.



# 4. DC & Switching Characteristics

### S51004-3.4

# Operating Conditions

Stratix<sup>®</sup> devices are offered in both commercial and industrial grades. Industrial devices are offered in -6 and -7 speed grades and commercial devices are offered in -5 (fastest), -6, -7, and -8 speed grades. This section specifies the operation conditions for operating junction temperature,  $V_{CCINT}$  and  $V_{CCIO}$  voltage levels, and input voltage requirements. The voltage specifications in this section are specified at the pins of the device (and not the power supply). If the device operates outside these ranges, then all DC and AC specifications are not guaranteed. Furthermore, the reliability of the device may be affected. The timing parameters in this chapter apply to both commercial and industrial temperature ranges unless otherwise stated.

Tables 4–1 through 4–8 provide information on absolute maximum ratings.

Table 4–1	Table 4–1. Stratix Device Absolute Maximum Ratings Notes (1), (2)											
Symbol	Parameter	Minimum	Maximum	Unit								
V <sub>CCINT</sub>	Supply voltage	With respect to ground	-0.5	2.4	V							
V <sub>CCIO</sub>			-0.5	4.6	V							
VI	DC input voltage (3)		-0.5	4.6	V							
I <sub>OUT</sub>	DC output current, per pin		-25	40	mA							
T <sub>STG</sub>	Storage temperature	No bias	-65	150	°C							
TJ	Junction temperature	BGA packages under bias		135	°C							

Table 4–2. Stratix Device Recommended Operating Conditions (Part 1 of 2)									
Symbol	Parameter Conditions Minimum Maximum								
V <sub>CCINT</sub>	Supply voltage for internal logic and input buffers	(4)	1.425	1.575	V				

**Table 4–53. Stratix Regional Clock External I/O Timing Parameters (Part 2 of 2)** Notes (1), (2)

Symbol	Parameter
t <sub>XZPLL</sub>	Synchronous IOE output enable register to output pin disable delay using regional clock fed by Enhanced PLL with default phase setting
t <sub>ZXPLL</sub>	Synchronous IOE output enable register to output pin enable delay using regional clock fed by Enhanced PLL with default phase setting

Notes to Table 4–53:

- (1) These timing parameters are sample-tested only.
- (2) These timing parameters are for column and row IOE pins. You should use the Quartus II software to verify the external timing for any pin.

Table 4–54 shows the external I/O timing parameters when using global clock networks.

<b>Table 4-</b> (2)	54. Stratix Global Clock External I/O Timing Parameters Notes (1),
Symbol	Parameter
t <sub>INSU</sub>	Setup time for input or bidirectional pin using IOE input register with global clock fed by ${\tt CLK}\xspace$ pin
t <sub>INH</sub>	Hold time for input or bidirectional pin using IOE input register with global clock fed by ${\tt CLK}$ pin
t <sub>outco</sub>	Clock-to-output delay output or bidirectional pin using IOE output register with global clock fed by CLK pin
t <sub>INSUPLL</sub>	Setup time for input or bidirectional pin using IOE input register with global clock fed by Enhanced PLL with default phase setting
t <sub>INHPLL</sub>	Hold time for input or bidirectional pin using IOE input register with global clock fed by Enhanced PLL with default phase setting
t <sub>OUTCOPLL</sub>	Clock-to-output delay output or bidirectional pin using IOE output register with global clock Enhanced PLL with default phase setting
t <sub>XZPLL</sub>	Synchronous IOE output enable register to output pin disable delay using global clock fed by Enhanced PLL with default phase setting
t <sub>ZXPLL</sub>	Synchronous IOE output enable register to output pin enable delay using global clock fed by Enhanced PLL with default phase setting

#### Notes to Table 4–54:

- (1) These timing parameters are sample-tested only.
- (2) These timing parameters are for column and row IOE pins. You should use the Quartus II software to verify the external timing for any pin.

Tables 4–67 through 4–72 show the external timing parameters on column and row pins for EP1S25 devices.

Table 4–67. EP1S25 External I/O Timing on Column Pins Using Fast Regional Clock Networks									
Parameter	-5 Spee	d Grade	-6 Speed Grade		-7 Speed Grade		-8 Speed Grade		l la it
	Min	Max	Min	Max	Min	Max	Min	Max	UIIII
t <sub>INSU</sub>	2.412		2.613		2.968		3.468		ns
t <sub>INH</sub>	0.000		0.000		0.000		0.000		ns
t <sub>OUTCO</sub>	2.196	4.475	2.196	4.748	2.196	5.118	2.196	5.603	ns
t <sub>xz</sub>	2.136	4.349	2.136	4.616	2.136	4.994	2.136	5.488	ns
t <sub>ZX</sub>	2.136	4.349	2.136	4.616	2.136	4.994	2.136	5.488	ns

Table 4–68. EP1S25 External I/O Timing on Column Pins Using Regional Clock Networks									
Doromotor	-5 Speed Grade		-6 Speed Grade		-7 Spee	d Grade	-8 Spee	Unit	
Farailleler	Min	Max	Min	Max	Min	Max	Min	Max	UIII
t <sub>INSU</sub>	1.535		1.661		1.877		2.125		ns
t <sub>INH</sub>	0.000		0.000		0.000		0.000		ns
t <sub>OUTCO</sub>	2.739	5.396	2.739	5.746	2.739	6.262	2.739	6.946	ns
t <sub>xz</sub>	2.679	5.270	2.679	5.614	2.679	6.138	2.679	6.831	ns
t <sub>ZX</sub>	2.679	5.270	2.679	5.614	2.679	6.138	2.679	6.831	ns
t <sub>INSUPLL</sub>	0.934		0.980		1.092		1.231		ns
t <sub>INHPLL</sub>	0.000		0.000		0.000		0.000		ns
t <sub>OUTCOPLL</sub>	1.316	2.733	1.316	2.839	1.316	2.921	1.316	3.110	ns
t <sup>XZPLL</sup>	1.256	2.607	1.256	2.707	1.256	2.797	1.256	2.995	ns
t <sub>ZXPLL</sub>	1.256	2.607	1.256	2.707	1.256	2.797	1.256	2.995	ns

Tables 4–105 through 4–108 show the output adder delays associated with column and row I/O pins for both fast and slow slew rates. If an I/O standard is selected other than 3.3-V LVTTL 4mA or LVCMOS 2 mA with a fast slew rate, add the selected delay to the external  $t_{OUTCO}$ ,  $t_{OUTCOPLL}$ ,  $t_{XZ}$ ,  $t_{ZX}$ ,  $t_{XZPLL}$ , and  $t_{ZXPLL}$  I/O parameters shown in Table 4–55 on page 4–36 through Table 4–96 on page 4–56.

Table 4–105.	Table 4–105. Stratix I/O Standard Output Delay Adders for Fast Slew Rate on Column Pins (Part 1 of 2)							of 2)		
Doromo		-5 Spee	d Grade	-6 Spee	d Grade	-7 Speed Grade		-8 Speed Grade		Unit
Farailleler		Min	Max	Min	Max	Min	Max	Min	Max	Unit
LVCMOS	2 mA		1,895		1,990		1,990		1,990	ps
	4 mA		956		1,004		1,004		1,004	ps
	8 mA		189		198		198		198	ps
	12 mA		0		0		0		0	ps
	24 mA		-157		-165		-165		-165	ps
3.3-V LVTTL	4 mA		1,895		1,990		1,990		1,990	ps
	8 mA		1,347		1,414		1,414		1,414	ps
	12 mA		636		668		668		668	ps
	16 mA		561		589		589		589	ps
	24 mA		0		0		0		0	ps
2.5-V LVTTL	2 mA		2,517		2,643		2,643		2,643	ps
	8 mA		834		875		875		875	ps
	12 mA		504		529		529		529	ps
	16 mA		194		203		203		203	ps
1.8-V LVTTL	2 mA		1,304		1,369		1,369		1,369	ps
	8 mA		960		1,008		1,008		1,008	ps
	12 mA		960		1,008		1,008		1,008	ps
1.5-V LVTTL	2 mA		6,680		7,014		7,014		7,014	ps
	4 mA		3,275		3,439		3,439		3,439	ps
	8 mA		1,589		1,668		1,668		1,668	ps
GTL			16		17		17		17	ps
GTL+			9		9		9		9	ps
3.3-V PCI			50		52		52		52	ps
3.3-V PCI-X 1.0	C		50		52		52		52	ps
Compact PCI			50		52		52		52	ps
AGP 1×			50		52		52		52	ps
AGP 2×			1,895		1,990		1,990		1,990	ps

Table 4–105. Stratix I/O Standard Output Delay Adders for Fast Slew Rate on Column Pins (Part 2 of 2)													
Parameter	-5 Speed Grade		-6 Speed Grade		-7 Speed Grade		-8 Speed Grade		11				
Farameter	Min	Max	Min	Max	Min	Max	Min	Max       1,021       755       153       712       234       1,083       469       693       564	Unit				
CTT		973		1,021		1,021		1,021	ps				
SSTL-3 Class I		719		755		755		755	ps				
SSTL-3 Class II		146		153		153		153	ps				
SSTL-2 Class I		678		712		712		712	ps				
SSTL-2 Class II		223		234		234		234	ps				
SSTL-18 Class I		1,032		1,083		1,083		1,083	ps				
SSTL-18 Class II		447		469		469		469	ps				
1.5-V HSTL Class I		660		693		693		693	ps				
1.5-V HSTL Class II		537		564		564		564	ps				
1.8-V HSTL Class I		304		319		319		319	ps				
1.8-V HSTL Class II		231		242		242		242	ps				

Table 4–106. Stratix I/O Standard Output Delay Adders for Fast Slew Rate on Row Pins   (Part 1 of the second sec								(Part 1 of	2)	
Baramatar		-5 Speed Grade		-6 Speed Grade		-7 Speed Grade		-8 Speed Grade		11-14
Falalit		Min	Max	Min	Max	Min	Max	Min	Max	Unit
LVCMOS	2 mA		1,518		1,594		1,594		1,594	ps
	4 mA		746		783		783		783	ps
	8 mA		96		100		100		100	ps
	12 mA		0		0		0		0	ps
3.3-V LVTTL	4 mA		1,518		1,594		1,594		1,594	ps
	8 mA		1,038		1,090		1,090		1,090	ps
	12 mA		521		547		547		547	ps
	16 mA		414		434		434		434	ps
	24 mA		0		0		0		0	ps
2.5-V LVTTL	2 mA		2,032		2,133		2,133		2,133	ps
	8 mA		699		734		734		734	ps
	12 mA		374		392		392		392	ps
	16 mA		165		173		173		173	ps
1.8-V LVTTL	2 mA		3,714		3,899		3,899		3,899	ps
	8 mA		1,055		1,107		1,107		1,107	ps
	12 mA		830		871		871		871	ps

Table 4–108.	Stratix I/O S	Standard	Output De	elay Adde	rs for Slo	w Slew R	ate on Ro	w Pins		
1/0.01	1d	-5 Spee	d Grade	-6 Spee	d Grade	-7 Spee	d Grade	-8 Speed Grade		11-14
i/U Stanuaru		Min	Max	Min	Max	Min	Max	Min	Max	Unit
LVCMOS	2 mA		1,571		1,650		1,650		1,650	ps
	4 mA		594		624		624		624	ps
	8 mA		208		218		218		218	ps
	12 mA		0		0		0		0	ps
3.3-V LVTTL	4 mA		1,571		1,650		1,650		1,650	ps
	8 mA		1,393		1,463		1,463		1,463	ps
	12 mA		596		626		626		626	ps
	16 mA		562		590		590		590	ps
2.5-V LVTTL	2 mA		2,562		2,690		2,690		2,690	ps
	8 mA		1,343		1,410		1,410		1,410	ps
	12 mA		864		907		907		907	ps
	16 mA		945		992		992		992	ps
1.8-V LVTTL	2 mA		6,306		6,621		6,621		6,621	ps
	8 mA		3,369		3,538		3,538		3,538	ps
	12 mA		2,932		3,079		3,079		3,079	ps
1.5-V LVTTL	2 mA		9,759		10,247		10,247		10,247	ps
	4 mA		6,830		7,172		7,172		7,172	ps
1.8-V LVTTL 1.5-V LVTTL GTL+	8 mA		5,699		5,984		5,984		5,984	ps
GTL+			-333		-350		-350		-350	ps
CTT			591		621		621		621	ps
SSTL-3 Class I			267		280		280		280	ps
SSTL-3 Class I	I		-346		-363		-363		-363	ps
SSTL-2 Class I			481		505		505		505	ps
SSTL-2 Class I	I		-58		-61		-61		-61	ps
SSTL-18 Class	I		2,207		2,317		2,317		2,317	ps
1.5-V HSTL Cla	ass I		1,966		2,064		2,064'		2,064	ps
1.8-V HSTL Cla	ass I		1,208		1,268		1,460		1,720	ps

FPLL[107]CLK Pins in Wire-Bond Packages (Part 2 of 2)									
I/O Standard	-6 Speed Grade	-7 Speed Grade	-8 Speed Grade	Unit					
LVCMOS	422	390	390	MHz					
GTL+	250	200	200	MHz					
SSTL-3 Class I	350	300	300	MHz					
SSTL-3 Class II	350	300	300	MHz					
SSTL-2 Class I	350	300	300	MHz					
SSTL-2 Class II	350	300	300	MHz					
SSTL-18 Class I	350	300	300	MHz					
SSTL-18 Class II	350	300	300	MHz					
1.5-V HSTL Class I	350	300	300	MHz					
1.8-V HSTL Class I	350	300	300	MHz					
CTT	250	200	200	MHz					
Differential 1.5-V HSTL C1	350	300	300	MHz					
LVPECL (1)	717	640	640	MHz					
PCML (1)	375	350	350	MHz					
LVDS (1)	717	640	640	MHz					
HyperTransport technology (1)	717	640	640	MHz					

Table A 110 Strativ Maximum Innut Clock Rate for CLKIN 2 9 111 Pins &

Table 4–119. Stratix Maximum Input Clock Rate for CLK[1, 3, 8, 10] Pins in Wire-Bond Packages (Part 1 of 2)

I/O Standard	-6 Speed Grade	-7 Speed Grade	-8 Speed Grade	Unit
LVTTL	422	390	390	MHz
2.5 V	422	390	390	MHz
1.8 V	422	390	390	MHz
1.5 V	422	390	390	MHz
LVCMOS	422	390	390	MHz
GTL+	250	200	200	MHz
SSTL-3 Class I	350	300	300	MHz
SSTL-3 Class II	350	300	300	MHz
SSTL-2 Class I	350	300	300	MHz
SSTL-2 Class II	350	300	300	MHz

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	<b>A</b>	-6 Speed Grade			-7 Speed Grade			-8 Speed Grade			
Symbol	Conditions	Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
SW	PCML (J = 4, 7, 8, 10) only	800			800			800			ps
	PCML (J = 2) only	1,200			1,200			1,200			ps
	PCML (J = 1) only	1,700			1,700			1,700			ps
	LVDS and LVPECL (J = 1) only	550			550			550			ps
	LVDS, LVPECL, HyperTransport technology (J = 2 through 10) only	500			500			500			ps
Input jitter tolerance (peak-to-peak)	All			250			250			250	ps
Output jitter (peak-to- peak)	All			200			200			200	ps
Output t <sub>RISE</sub>	LVDS	80	110	120	80	110	120	80	110	120	ps
	HyperTransport technology	120	170	200	120	170	200	120	170	200	ps
	LVPECL	100	135	150	100	135	150	100	135	150	ps
	PCML	80	110	135	80	110	135	80	110	135	ps
Output t <sub>FALL</sub>	LVDS	80	110	120	80	110	120	80	110	120	ps
	HyperTransport	110	170	200	110	170	200	110	170	200	ps
	LVPECL	100	135	160	100	135	160	100	135	160	ps
	PCML	110	145	175	110	145	175	110	145	175	ps
t <sub>DUTY</sub>	LVDS (J = 2 through10) only	47.5	50	52.5	47.5	50	52.5	47.5	50	52.5	%
	LVDS (J =1) and LVPECL, PCML, HyperTransport technology	45	50	55	45	50	55	45	50	55	%
t <sub>LOCK</sub>	All			100			100			100	μs